

Search Notes

Application/Control No.

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Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

SHIGEMATSU ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
713	186	3/4/2006	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, INVENTOR <i>name Search</i>	3/4/3006	ECT